

Notice of References Cited	Application/Control No. 10/766,465	Applicant(s)/Patent Under Reexamination MA ET AL.	
	Examiner Su C. Kim	Art Unit 2823	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	General property of gate oxide and field oxide at http://semiconductorglossary.com/ (search word field oxide & gate oxide)
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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